

Preface

We are excited to welcome you to the Passive and Active Measurement Conference (PAM) 2015 in New York, NY, USA. PAM seeks to bring together the network research and operations communities, to consider network measurement and analysis techniques, particularly those in the earlier stages of research.

PAM's focus is on research and practical applications of network measurement, measurement of networked applications, content distribution networks, online social networks, overlay networks, and more. Measurement technology is needed at all layers of the stack: for power profiling of hardware components; at the MAC/network/transport layers; as well as up the stack for application profiling and even to collect user feedback. Measurement technologies are being designed for the digital home, residential access networks, wireless and mobile access, enterprise, ISP, and data center networks.

PAM encourages a broad range of submissions across these recently important topics. We aim to understand the role that measurement techniques can play in networked environments and applications, across different layers, and how they can serve as critical building blocks for broader measurement needs. At the same time, PAM also continues with its original goal, to expand the techniques, tools, and practical uses of network measurement technology.

Submission Statistics

This year, PAM has received 100 submissions. Each submission was reviewed by at least three reviewers, judging its technical content, intellectual merit, and clarity of writing. After the initial review process, the reviewers discussed all submissions until they reached consensus to accept or reject. There were 27 accepted papers.

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